Gantner

Measurement Module for Strain Gage and LVDT/RVDT

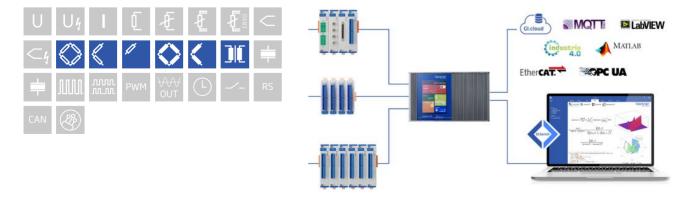
Q.raxx XL is a new addition to the Q.series product family - the ideal 19" rackmount DAQ solution for applications that require high channel density and custom sensor terminations. Q.raxx XL DAQ systems can utilize an integrated, high-performance controller for communication, control, and data logging purposes. With a controller, multiple Q.raxx XL systems can be synchronized to each other allowing for efficient DAQ distribution with low jitter and gradual expansion up to thousands of channels.

- High Density up to 13 I/O modules per Q.raxx 3U chassis with up to 16 channels per I/O module
- User Friendly front panel indicators for module status, power, and input range error
- Fully Customizable multiple front panel termination options available
- Maximum Flexibility parallel communication available in TCP/IP, CAN, PROFIBUS, Modbus, and EtherCAT
- Gantner's Quality Standard integrated filtering, galvanic isolation & signal/sensor conditioning per channel



Key Features

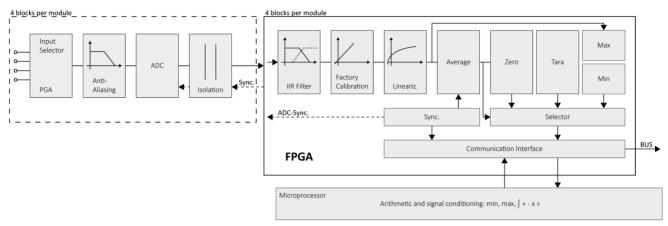
- 4 galvanically isolated analog inputs channels strain gage and inductive half and full bridges, LVDT, RVDT quarter bridge with completion terminal
- Carrier frequency (CF) principle
 4.8 kHz carrier frequency
- High-accuracy digitization
 24 bit ADU, 20 kHz sample rate per channel
- Signal conditioning linearization, filtering, average, scaling, min/max, RMS, arithmetic, alarm
- 3-Way galvanic isolation
 500 VDC channel to channel, channel to power supply, and channel to bus





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Block diagram



Technical Data

Analog Input

Channels	4
Accuracy	0.02 % typical
	0.05 % in controlled environment ¹
	0.1 % in industrial area ²
Linearity error	0.02 % typical full-scale
Repeatability	0.01 % typical (within 24 hrs)
Input impedance	>10 MΩ
Isolation voltage	500 VDC channel to channel, to power supply, channel to bus ³

 $^{\rm 1}\,$ according to EN 61326 2006: appendix B

² according to EN 61326 2006: appendix A

 $^{\rm 3}\,$ noise pulses up to 1000 VDC, continuous up to 250 VDC

Measurement Module for Strain Gage and LVDT/RVDT



Strain Gage Measurement

Bridge configuration(s)	resistive full-bridge (4/w resistive half-bridge (3/w		
Allowable sensor cable length	< 30 m		
Shunt resistor	100 kΩ internal resistor		
Bridge excitation	2.5 or 5 Veff, 4.8 kHz AC e	excitation	
Bridge excitation stability	<0.01% / 24 hrs		
Bridge excitation drift	<0.02% / 10 K		
	5 Veff	2.5 Veff	
Allowable sensor resistance	>300 Ω	>100 Q	
Input range	±1.25 mV/V	±2.5 mV/V	
	±2.5 mV/V	±5 mV/V	
	±25 mV/V	±50 mV/V	
	±50 mV/V	±100 mV/V	
	±100 mV/V	±200 mV/V	
	±200 mV/V	±400 mV/V	
	±500 mV/V	±1000 mV/V	
Long-term stability	< 0.1 µV/V / 24 hrs	<1 µV/V / 8000 hrs	
Temperature drift (range 2.5 mV/V)	<0.2 µV/V / 10 K Offset drift	< 0.05 % / 10 K Gain drift	
Signal-to-noise ratio	<0.3 µV/V at 10 Hz	<1 µV/V at 100 Hz	

LVDT/RVDT Measurement

Sensor connection	3- / 4-wire	
Sensor excitation (selectable)	5 Veff	2.5 Veff
Allowable sensor resistance	>300 Ω	>100 Q
Input range	±1.25 mV/V	±2.5 mV/V
	±2.5 mV/V	±5 mV/V
	±25 mV/V	±50 mV/V
	±50 mV/V	±100 mV/V
	±100 mV/V	±200 mV/V
	±200 mV/V	±400 mV/V
	±250 mV/V	±500 mV/V
	±500 mV/V	±1000 mV/V
Allowable sensor cable length	<100 m ¹	
Long-term stability	<0.1 µV/V / 24 hrs	<1 µV/V / 8000 hrs
Temperature drift (range 2.5 mV/V)	<0.2 µV/V / 10 K Offset drift	< 0.05 % / 10 K Gain drift
Signal-to-noise ratio	<0.3 µV/V at 10 Hz	<1 µV/V at 100 Hz

¹ low capacity sensor cable is strongly recommended

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Analog-to-Digital Conversion

Resolution	24-bit
Sample rate	20 kHz per channel
Modulation method	sigma-delta
Anti-aliasing filter	1 kHz, 3th order (4.8 kHz CF excitation)
Digital filters	Infinite impulse response (IIR), low-pass, high-pass, band-pass, band-stop, Butterworth or Bessel (2nd, 4th, 6th or 8th order), frequency range 0.1 Hz to 1 kHz in steps of 0.1 (adjustable via software)
Averaging	configurable or automatic according to the user-defined data rate

Communication Interface Localbus

Protocols	proprietary Localbus (115200 bps to 48 Mbps, latency <100 ns) ASCII (19200 bps to 115200 bps) Modbus RTU
Data format	8E1
Electrical standard	ANSI/TIA/EIA-485-A, 2-wire

Power Supply

Input voltage	10 to 30 VDC, overvoltage and overcurrent protection
Power consumption	2.5 W (approx.)
Input voltage influence	<0.001 % / V

Environmental Specifications

Electromagnetic compatibility (EMC)	according to IEC 61000-4 and EN 55011
Operating temperature	-20°C to +60°C
Storage temperature	-40°C to +85°C
Relative humidity	5 - 95 % at 50°C (non-condensing)

Remarks

Validity of all listed specifications are subject to a warm-up period of at least 45 minutes	
Specifications subject to change without notice	

Mechanical information

Material	Aluminum
Measurements (W x H x D)	30x 128 x 120mm
Weight	approx. 200 g

Ordering Information

Article number 675935

Measurement Module for Strain Gage and LVDT/RVDT



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